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**7810**

8 Opacity. Action item 2006-10/04 is completed and should be closed. See 1N1369 for test results.

9.4.1 IC cards with contacts (static electricity) Please provide the test results to support the change to 4000 volts from 2000 volts. Note that the PDAM 1N1638r gives the voltage as 2000 volts for the same test, both documents should have the same voltage requirement.

**1N1699 FDIS 14443-1**

1. Scope

Scope is poorly defined, for example, what are "not in those formats"? Define "international standard card formats", are these ID-1, or TD-3? If so they should be specified as such.

3. Definitions

Do not repeat the ID-1 definition, refer to it in the opening sentence:

For the purposes of this part of ISO/IEC 14443, the definition given in ISO/IEC 7810 for ID-1 and the following apply.

4.2 Antenna

Combine normative portion of NOTE 1 with requirement in 4.2 since notes are informative.

Delete NOTE 1 and change text of 4.2 to:

For all forms of PICC and including any warpage of the finished PICC, all parts of the PICC antenna shall be contained within a maximum volume of 86 mm x 54 mm x 3 mm.

A.1.2 Loading effect

More description is needed to define what this test is for. Title of clause should match terms used for test method.